Notice of References Cited Application/Control No. 10/598,502 Applicant(s)/Patent Under Reexamination NAKAMURA ET AL. Examiner Art Unit Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2007/0215463	09-2007	PARKHE, VIJAY D.	204/298.12
*	В	US-2007/0187236	08-2007	Nakamura et al.	204/298.12
*	C	US-6,153,315	11-2000	Yamakoshi et al.	428/687
*	D	US-5,460,793	10-1995	Kano et al.	423/344
*	Е	US-4,895,592	01-1990	Hatwar et al.	75/10.14
	F	US-			
	G	US-			
	Ι	US-			
	-	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 2002-208125	07-2002	Japan	Ueno	C23C 14/34
	0	JP 2002-069623	03-2002	Japan	Ueno	C23C 14/34
	Ρ					
	Ø					
	R					
	Ø					
	Τ					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.